CDCVF2509

SCAS737D - APRIL 2004 - REVISED FEBRUARY 2010

3.3-V PHASE-LOCK LOOP CLOCK DRIVER

Check for Samples: CDCVF2509

FEATURES

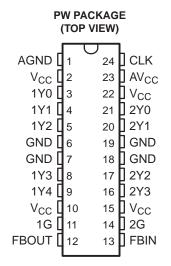
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- Use CDCVF2509A (SCAS765) as a Replacement for This Device
- Designed to Meet and Exceed PC133 SDRAM Registered DIMM Specification Rev. 1.1
- Spread Spectrum Clock Compatible
- Operating Frequency 50 MHz to 175 MHz
- Static Phase Error Distribution at 66 MHz to 166 MHz Is ±125 ps
- Jitter (cyc cyc) at 66 MHz to 166 MHz Is
 Typ = 70 ps
- Advanced Deep Submicron Process
 Results in More Than 40% Lower Power
 Consumption Versus Current Generation
 PC133 Devices
- Available in Plastic 24-Pin TSSOP
- Phase-Lock Loop Clock Distribution for Synchronous DRAM Applications
- Distributes One Clock Input to One Bank of Five and One Bank of Four Outputs
- Separate Output Enable for Each Output Bank
- External Feedback (FBIN) Terminal Is Used to Synchronize the Outputs to the Clock Input

- 25-Ω On-Chip Series Damping Resistors
- No External RC Network Required
- Operates at 3.3 V

APPLICATIONS

- DRAM Applications
- PLL Based Clock Distributors
- Non-PLL Clock Buffer



DESCRIPTION

The CDCVF2509 is a high-performance, low-skew, low-jitter, phase-lock loop (PLL) clock driver. It uses a PLL to precisely align, in both frequency and phase, the feedback (FBOUT) output to the clock (CLK) input signal. It is specifically designed for use with synchronous DRAMs. The CDCVF2509 operates at a 3.3-V V_{CC}. It also provides integrated series-damping resistors that make it ideal for driving point-to-point loads.

One bank of five outputs and one bank of four outputs provide nine low-skew, low-jitter copies of CLK. Output signal duty cycles are adjusted to 50%, independent of the duty cycle at CLK. Each bank of outputs is enabled or disabled separately via the control (1G and 2G) inputs. When the G inputs are high, the outputs switch in phase and frequency with CLK; when the G inputs are low, the outputs are disabled to the logic-low state.

Unlike many products containing PLLs, the CDCVF2509 does not require external RC networks. The loop filter for the PLL is included on-chip, minimizing component count, board space, and cost.



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These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

DESCRIPTION CONTINUED

Because it is based on PLL circuitry, the CDCVF2509 requires a stabilization time to achieve phase lock of the feedback signal to the reference signal. This stabilization time is required following power up and application of a fixed-frequency, fixed-phase signal at CLK, and following any changes to the PLL reference or feedback signals. The PLL can be bypassed by strapping AV_{CC} to ground.

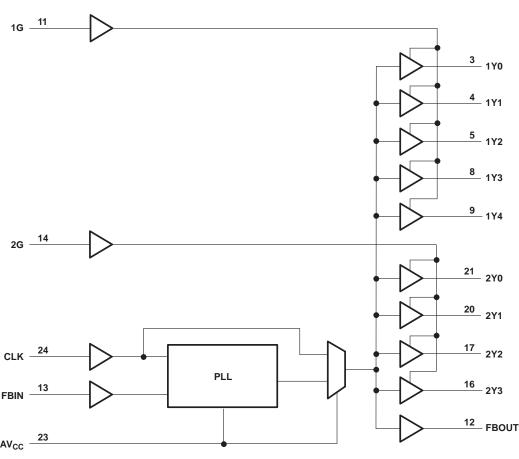
The CDCVF2509A is characterized for operation from 0°C to 85°C.

For application information, see application reports *High Speed Distribution Design Techniques for CDC509/516/2509/2510/2516* (SLMA003) and *Using CDC2509A/2510A PLL with Spread Spectrum Clocking (SSC)* (SCAA039).

FUNCTION TABLE

	INPUTS		OUTPUTS					
1G	2G	CLK	1Y (0:4)	2Y (0:3)	FBOUT			
X	X	L	L	L	L			
L	L	Н	L	L	Н			
L	Н	Н	L	Н	Н			
Н	L	Н	Н	L	Н			
Н	Н	Н	Н	Н	Н			

FUNCTIONAL BLOCK DIAGRAM



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AVAILABLE OPTIONS

T	PACKAGE					
TA	SMALL OUTLINE (PW)					
0°C to 05°C	CDCVF2509PWR					
0°C to 85°C	CDCVF2509PW					

PACKAGE THERMAL RESISTANCE(1)

	CDCVF2509APW 24-PIN TS	SEOD	Th	HERMAL AIF	RFLOW (CF	M)	UNIT
	CDCVF2509AFW 24-FIN 13	0	150	250	500	UNIT	
$R_{\theta JA}$	High K	88	83	81	77	00/11/	
$R_{\theta JC}$	High K	26.5					°C/W

(1) The package thermal impedance is calculated in accordance with JESD 51 and JEDEC2S2P (high-k board).

Pin Functions

	PIN	TVD=	DECODINE
NAME	NO.	TYPE	DESCRIPTION
CLK	24	I	Clock input. CLK provides the clock signal to be distributed by the CDCVF2509A clock driver. CLK is used to provide the reference signal to the integrated PLL that generates the clock output signals. CLK must have a fixed frequency and fixed phase for the PLL to obtain phase lock. Once the circuit is powered up and a valid CLK signal is applied, a stabilization time is required for the PLL to phase lock the feedback signal to its reference signal.
FBIN	13	I	Feedback input. FBIN provides the feedback signal to the internal PLL. FBIN must be hard-wired to FBOUT to complete the PLL. The integrated PLL synchronizes CLK and FBIN so that there is nominally zero phase error between CLK and FBIN.
1G	11	I	Output bank enable. 1G is the output enable for outputs 1Y(0:4). When 1G is low, outputs 1Y(0:4) are disabled to a logic-low state. When 1G is high, all outputs 1Y(0:4) are enabled and switch at the same frequency as CLK.
2G	14	I	Output bank enable. 2G is the output enable for outputs 2Y(0:3). When 2G is low, outputs 2Y(0:3) are disabled to a logic low state. When 2G is high, all outputs 2Y(0:3) are enabled and switch at the same frequency as CLK.
FBOUT	12	0	Feedback output. FBOUT is dedicated for external feedback. It switches at the same frequency as CLK. When externally wired to FBIN, FBOUT completes the feedback loop of the PLL. FBOUT has an integrated $25-\Omega$ series-damping resistor.
1Y (0:4)	3, 4, 5, 8, 9	0	Clock outputs. These outputs provide low-skew copies of CLK. Output bank 1Y(0:4) is enabled via the 1G input. These outputs can be disabled to a logic-low state by deasserting the 1G control input. Each output has an integrated $25-\Omega$ series-damping resistor.
2Y (0:3)	16, 17, 21, 20	0	Clock outputs. These outputs provide low-skew copies of CLK. Output bank 2Y(0:3) is enabled via the 2G input. These outputs can be disabled to a logic-low state by deasserting the 2G control input. Each output has an integrated $25-\Omega$ series-damping resistor.
AV _{CC}	23	Power	Analog power supply. AV_{CC} provides the power reference for the analog circuitry. In addition, AV_{CC} can be used to bypass the PLL. When AV_{CC} is strapped to ground, PLL is bypassed and CLK is buffered directly to the device outputs.
AGND	1	Ground	Analog ground. AGND provides the ground reference for the analog circuitry.
V _{CC}	2, 10, 15, 22	Power	Power supply
GND	6, 7, 18, 19	Ground	Ground

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ABSOLUTE MAXIMUM RATINGS

over operating free-air temperature range (unless otherwise noted)(1)

		UNIT
AV_{CC}	Supply voltage range (2)	AV _{CC} < V _{CC} +0.7 V
V _{CC}	Supply voltage range	−0.5 V to 4.3 V
V _I	Input voltage range (3)	−0.5 V to 4.6 V
Vo	Voltage range applied to any output in the high or low state (3) (4)	-0.5 V to V _{CC} + 0.5 V
I _{IK}	Input clamp current (V _I < 0)	–50 mA
I _{OK}	Output clamp current (V _O < 0 or V _O > V _{CC})	±50 mA
Io	Continuous output current (V _O = 0 to V _{CC})	±50 mA
	Continuous current through each V _{CC} or GND	±100 mA
	Maximum power dissipation at T _A = 55°C (in still air) ⁽⁵⁾	0.7 W
T _{stg}	Storage temperature range	−65°C to 150°C

- (1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- 2) AV_{CC} must not exceed V_{CC}+ 0.7 V
- (3) The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
- (4) This value is limited to 4.6 V maximum.
- (5) The maximum package power dissipation is calculated using a junction temperature of 150°C and a board trace length of 750 mils. For more information, see the *Package Thermal Considerations* application note in the *ABT Advanced BiCMOS Technology Data Book* (SCBD002).

DISSIPATION RATINGS

PACKAGE	BOARD TYPE	$R_{ hetaJA}$	T _A ≤ 25°C POWER RATING	DERATING FACTORS ABOVE $T_A \le 25^{\circ}C$	T _A = 70°C POWER RATING	T _A = 85°C POWER RATING
PW	JEDEC low-K	114.5°C/W	920 mW	8.7 mW/°C	520 mW	390 mW
	JEDEC high-K	62.1°C/W	1690 mW	16.1 mW/°C	960 mW	720 mW

RECOMMENDED OPERATING CONDITIONS⁽¹⁾

		MIN	MAX	UNIT
V _{CC} , AV _{CC}	Supply voltage	3	3.6	V
V _{IH}	High-level input voltage	2		V
V_{IL}	Low-level input voltage		0.8	V
V_{I}	Input voltage	0	V_{CC}	V
I _{OH}	High-level output current		-12	mA
I _{OL}	Low-level output current		12	mA
T _A	Operating free-air temperature	0	85	°C

⁽¹⁾ Unused inputs must be held high or low to prevent them from floating.

TIMING REQUIREMENTS

over recommended ranges of supply voltage and operating free-air temperature

		MIN	MAX	UNIT
f _{clk}	Clock frequency	50	175	MHz
	Input clock duty cycle	40%	60%	
	Stabilization time ⁽¹⁾		1	ms

The time required for the integrated PLL circuit to obtain phase lock of its feedback signal to its reference signal. For phase lock to be obtained, a fixed-frequency, fixed-phase reference signal must be present at CLK. Until phase lock is obtained, the specifications for propagation delay, skew and jitter parameters given in the switching characteristics table are not applicable. This parameter does not apply for input modulation under SSC application.

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ELECTRICAL CHARACTERISTICS

over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	V _{CC} , AV _{CC}	MIN	TYP ⁽¹⁾	MAX	UNIT
V_{IK}	Input clamp voltage	I _I = -18 mA	3 V			-1.2	V
		I _{OH} = -100 μA	MIN to MAX	V _{CC} -0.2			
V_{OH}	High-level output voltage	I _{OH} = -12 mA	3 V	2.1			V
		$I_{OH} = -6 \text{ mA}$	3 V	2.4			
		$I_{OL} = 100 \mu A$	MIN to MAX			0.2	
V_{OL}	Low-level output voltage	I _{OL} = 12 mA	3 V			8.0	V
		I _{OL} = 6 mA	3 V			0.55	
		V _O = 1 V	3 V	-28			
I _{OH}	High-level output current	V _O = 1.65 V	3.3 V		-36		mA
ЮН		V _O = 3.135 V	3.6 V			-8	
		V _O = 1.95 V	3 V	30			
I _{OL}	Low-level output current	V _O = 1.65 V	3.3 V		40		mA
		V _O = 0.4 V	3.6 V			10	
I	Input current	$V_I = V_{CC}$ or GND	3.6 V			±5	μΑ
I _{CC} (2)	Supply current (static, output not switching)	V _I = V _{CC} or GND, I _O = 0, Outputs: low or high	3.6 V, 0 V			40	μΑ
ΔI_{CC}	Change in supply current	One input at V _{CC} - 0.6 V, Other inputs at V _{CC} or GND	3.3 V to 3.6 V			500	μΑ
Ci	Input capacitance	$V_I = V_{CC}$ or GND	3.3 V		2.5		pF
C _o	Output capacitance	$V_O = V_{CC}$ or GND	3.3 V		2.8		pF

For conditions shown as MIN or MAX, use the appropriate value specified under the recommended operating conditions section.

SWITCHING CHARACTERISTICS

over recommended ranges of supply voltage and operating free-air temperature, $C_L = 25 \text{ pF}$ (see Figure 1 and Figure 2)⁽¹⁾ (2)

	PARAMETER	FROM	TO	V _{CC} , A	UNIT		
		(INPUT)	(OUTPUT)	MIN	TYP	MAX	
t _(ф)	Phase error time- static (normalized) (see Figure 3 through Figure 6)	CLK↑ = 66 MHz to 166 MHz	FBIN↑	-125		125	ps
t _{sk(o)}	Output skew time ⁽³⁾	Any Y	Any Y			100	ps
	Phase error time-jitter (4)	CLK = 66 MHz to 100 MHz	Any Y or FBOUT	-50		50	ps
	litter (and Figure 7)	CLK = 66 MHz to 100 MHz	Amerika n EDOLIT		-70		
	Jitter _(cycle-cycle) (see Figure 7)	CLK = 100 MHz to 166 MHz	Any Y or FBOUT		-65		ps
	Duty cycle	f _(CLK) > 60 MHz	Any Y or FBOUT	45%		55%	
t _r	Rise time	$V_0 = 0.4 \text{ V to 2 V}$	Any Y or FBOUT	0.3		1.1	ns/V
t _f	Fall time	$V_0 = 2 \text{ V to } 0.4 \text{ V}$	Any Y or FBOUT	0.3		1.1	ns/V
t _{PLH}	Low-to-high propagation delay time, bypass mode	CLK	Any Y or FBOUT	1.8		3.9	ns
t _{PHL}	High-to-low propagation delay time, bypass mode	CLK	Any Y or FBOUT	1.8		3.9	ns

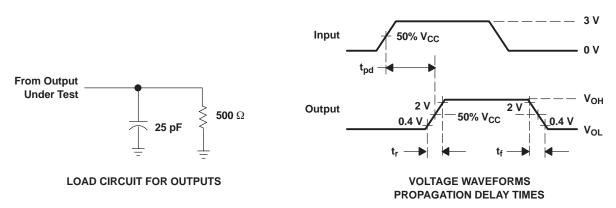
The specifications for parameters in this table are applicable only after any appropriate stabilization time has elapsed.

For dynamic I_{CC} vs Frequency, see Figure 8 and Figure 9.

These parameters are not production tested. The $t_{sk(o)}$ specification is only valid for equal loading of all outputs. Calculated per PC DRAM SPEC ($t_{phase\ error}$, static-jitter($c_{ycle-to-cycle}$).

/ Texas

PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and jig capacitance.

- B. All input pulses are supplied by generators having the following characteristics: PRR \leq 133 MHz, $Z_O = 50 \Omega$, $t_f \leq$ 1.2 ns. $t_f \leq$ 1.2 ns.
- C. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms

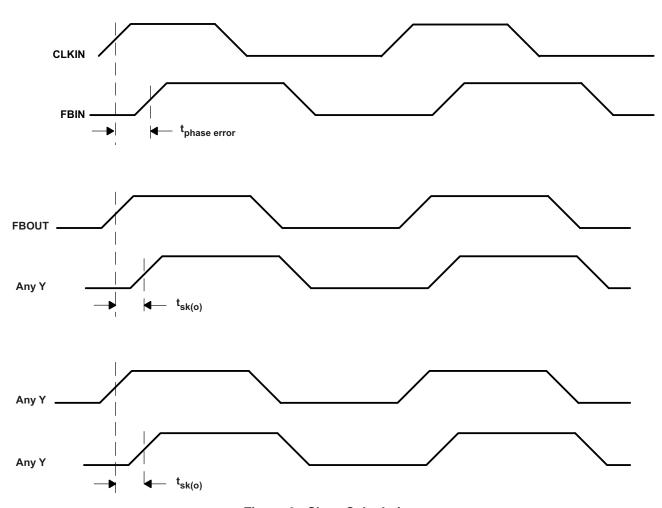


Figure 2. Skew Calculations



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TYPICAL CHARACTERISTICS

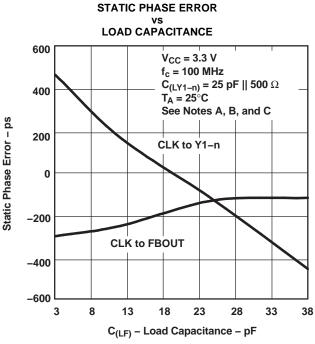


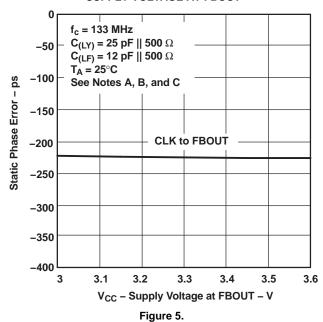
Figure 3.

LOAD CAPACITANCE 600 $V_{CC} = 3.3 V$ $f_c = 133 \text{ MHz}$ $C_{(LY1-n)}$ = 25 pF || 500 Ω T_A = 25°C 400 See Notes A, B, and C Static Phase Error - ps 200 CLK to Y1-n 0 -200 **CLK to FBOUT** -400 -600 3 8 13 18 23 28 33 38 C_(LF) - Load Capacitance - pF

STATIC PHASE ERROR

Figure 4.

STATIC PHASE ERROR VS SUPPLY VOLTAGE AT FBOUT



STATIC PHASE ERROR VS CLOCK FREQUENCY

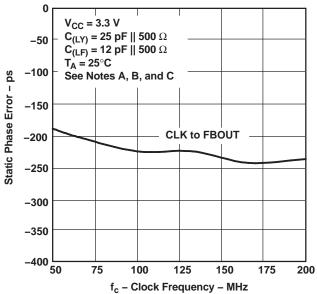
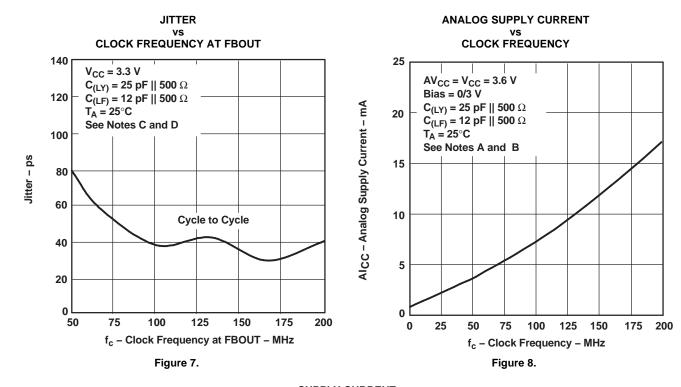


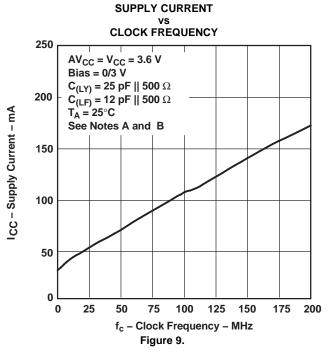
Figure 6.

- a. Trace length FBOUT to FBIN = 5 mm, Z_O = 50Ω
- b. $C_{(LY)}$ = Lumped capacitive load Y_{1-n}
- c. $C_{(LFx)}$ = Lumped feedback capacitance at FBOUT = FBIN

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- a. Trace length FBOUT to FBIN = 5 mm, Z_O = 50 Ω
- b. $C_{(LY)} = Lumped$ capacitive load Y_{1-n}
- c. $C_{(LFx)}$ = Lumped feedback capacitance at FBOUT = FBIN
- d. $C_{(LFx)}$ = Lumped feedback capacitance at FBOUT = FBIN.



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REVISION HISTORY

Ch	nanges from Original (April 2004) to Revision A	Page
•	Added CDCVF2509PW package number to the AVAILABLE OPTIONS table	3
Ch	nanges from Revision A (July 2004) to Revision B	Page
•	Changed Rise time values in the Switching Characteristics table From: Min =0.5 Max = 2.5 To: Min = 0.3 Max = 1.1	5
•	Changed Fall time values in the Switching Characteristics table From: $Min = 0.5 Max = 2.5 To$: $Min = 0.3 Max = 1.1$.	5
•	Changed Low-to-high propagation delay time values in the Switching Characteristics table From: Min =0.4 Max = 2.3 To: Min = 1.8 Max = 3.9	5
•	Changed High-to-low propagation delay time values in the Switching Characteristics table From: Min =0.4 Max = 2.3 To: Min = 1.8 Max = 3.9	
Ch	nanges from Revision B (June 2005) to Revision C	Page
•	Added NOT RECOMMENDED FOR NEW DESIGNS	1
Ch	nanges from Revision C (January 2009) to Revision D	Page
•	Added the PACKAGE THERMAL RESISTANCE table	3





11-Apr-2013

PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Top-Side Markings	Samples
	(1)		- J		-	` ′		1,		· · · · · · · · · · · · · · · · · · ·	
CDCVF2509PW	ACTIVE	TSSOP	PW	24	60	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 85	CKV2509	Samples
CDCVF2509PWG4	ACTIVE	TSSOP	PW	24	60	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 85	CKV2509	Samples
CDCVF2509PWR	ACTIVE	TSSOP	PW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 85	CKV2509	Samples
CDCVF2509PWRG4	ACTIVE	TSSOP	PW	24	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	0 to 85	CKV2509	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

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⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ Multiple Top-Side Markings will be inside parentheses. Only one Top-Side Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Top-Side Marking for that device.





11-Apr-2013

PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





_		
		Dimension designed to accommodate the component width
	B0	Dimension designed to accommodate the component length
	K0	Dimension designed to accommodate the component thickness
	W	Overall width of the carrier tape
ı	P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing			Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CDCVF2509PWR	TSSOP	PW	24	2000	330.0	16.4	6.95	8.3	1.6	8.0	16.0	Q1

PACKAGE MATERIALS INFORMATION

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*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)	
CDCVF2509PWR	TSSOP	PW	24	2000	367.0	367.0	38.0	

PW (R-PDSO-G24)

PLASTIC SMALL OUTLINE



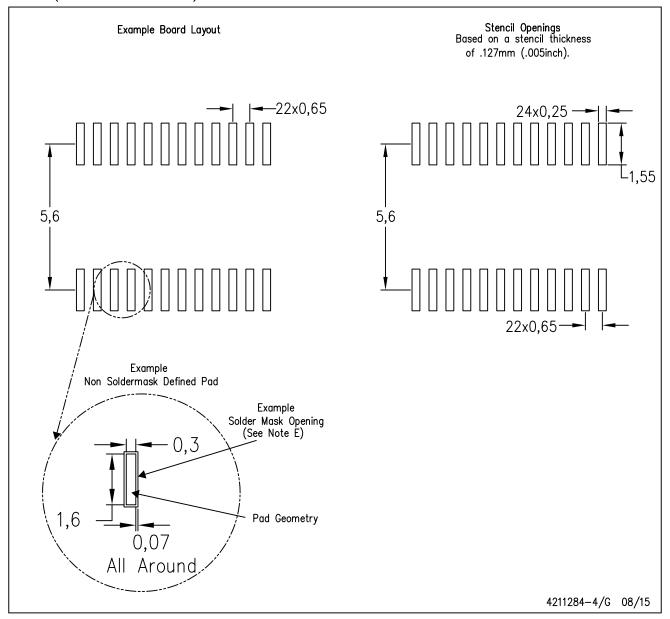
NOTES:

- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M—1994.
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
- E. Falls within JEDEC MO-153



PW (R-PDSO-G24)

PLASTIC SMALL OUTLINE



NOTES:

- All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.C. Publication IPC-7351 is recommended for alternate design.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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